

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/693,605	INUI ET AL.	
	Examiner	Art Unit	
	Alain L. Bashore	1792	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
427	162-165	12/17/2007	AB
430	321,394	12/17/2007	AB
430	290	12/17/2007	ab